EIE Electronics and Instrumentation Engineering

Section 1: Engineering Mathematics

Linear Algebra: Matrix algebra, systems of linear equations, consistency and rank, Eigenvalue and Eigenvectors.

Calculus: Mean value theorems, theorems of integral calculus, partial derivatives, maxima and minima, multiple integrals, Fourier series, vector identities, line, surface and volume integrals, Stokes, Gauss and Green's theorems.

Differential Equations: First order equation (linear and nonlinear), second order linear differential equations with constant coefficients, method of variation of parameters, Cauchy's and Euler's equations, initial and boundary value problems, solution of partial differential equations: variable separable method.

Analysis of Complex Variables: Analytic functions, Cauchy's integral theorem and integral formula, Taylor's and Laurent's series, residue theorem, solution of integrals.

Probability and Statistics: Sampling theorems, conditional probability, mean, median, mode, standard deviation and variance; random variables: discrete and continuous distributions: normal, Poisson and binomial distributions.

Numerical Methods: Matrix inversion, solutions of non-linear algebraic equations, iterative methods for solving differential equations, numerical integration, regression and correlation analysis.

Section 2: Networks, Signals and Systems

Circuit Analysis: Node and mesh analysis, superposition, Thevenin's theorem, Norton's theorem, reciprocity. Sinusoidal steady state analysis: phasors, complex power, maximum power transfer. Time and frequency domain analysis of linear circuits: RL, RC and RLC circuits, solution of network equations using Laplace transform.

Linear 2-port network parameters, wye-delta transformation.

Continuous-time Signals: Fourier series and Fourier transform, sampling theorem and applications.

Discrete-time Signals: DTFT, DFT, z-transform, discrete-time processing of continuous-time signals. LTI systems: definition and properties, causality, stability, impulse response, convolution, poles and zeroes, frequency response, group delay, phase delay.

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Syllabus for the written test for the post of Assistant Professor (L-10) (On Contract) Electronics and Instrumentation Engineering

Section 3: Electronic Devices

Energy bands in intrinsic and extrinsic semiconductors, equilibrium carrier concentration, direct and indirect band-gap semiconductors.

Carrier Transport: Diffusion current, drift current, mobility and resistivity, generation and recombination of carriers, Poisson and continuity equations.

P-N junction, Zener diode, BJT, MOS capacitor, MOSFET, LED, photo diode and solar cell.

Section 4: Control Systems

Feedback principles, signal flow graphs, transient response, steady-state-errors, Bode plot, phase and gain margins, Routh and Nyquist criteria, root loci, design of lead, lag and lead- lag compensators, state-space representation of systems; time-delay systems; mechanical, hydraulic and pneumatic system components, synchro pair, servo and stepper motors, servo valves; on-off, P, PI, PID, cascade, feed forward, and ratio controllers, tuning of PID controllers and sizing of control valves.

Section 5: Analog Electronics

Characteristics and applications of diode, Zener diode, BJT and MOSFET; small signal analysis of transistor circuits, feedback amplifiers. Characteristics of ideal and practical operational amplifiers; applications of opamps: adder, subtractor, integrator, differentiator, difference amplifier, instrumentation amplifier, precision rectifier, active filters, oscillators, signal generators, voltage controlled oscillators and phase locked loop, sources and effects of noise and interference in electronic circuits.

Section 6: Digital Electronics

Combinational logic circuits, minimization of Boolean functions. IC families: TTL and CMOS. Arithmetic circuits, comparators, Schmitt trigger, multi-vibrators, sequential circuits, flipflops, shift registers, timers and counters; sample-and-hold circuit, multiplexer, analog- to-digital (successive approximation, integrating, flash and sigma-delta) and digital-to- analog converters (weighted R, R-2R ladder and current steering logic). Characteristics of ADC and DAC (resolution, quantization, significant bits, conversion/settling time); basics of number systems, Embedded Systems: Microprocessor and microcontroller applications, memory and input-output interfacing; basics of data acquisition systems, basics of distributed control systems (DCS) and programmable logic controllers (PLC).

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Section 7: Measurements

SI units, standards (R, L, C, voltage, current and frequency), systematic and random errors in measurement, expression of uncertainty - accuracy and precision, propagation of errors, linear and weighted regression. Bridges: Wheatstone, Kelvin, Megohm, Maxwell, Anderson, Schering and Wien for measurement of R, L, C and frequency, Q-meter. Measurement of voltage, current and power in single and three phase circuits; ac and dc current probes; true rms meters, voltage and current scaling, instrument transformers, timer/counter, time, phase and frequency measurements, digital voltmeter, digital multimeter; oscilloscope, shielding and grounding.

Section 8: Sensors and Industrial Instrumentation

Resistive-, capacitive-, inductive-, piezoelectric-, Hall effect sensors and associated signal conditioning circuits; transducers for industrial instrumentation: displacement (linear and angular), velocity, acceleration, force, torque, vibration, shock, pressure (including low pressure), flow (variable head, variable area, electromagnetic, ultrasonic, turbine and open channel flow meters) temperature (thermocouple, bolometer, RTD (3/4 wire), thermistor, pyrometer and semiconductor); liquid level, pH, conductivity and viscosity measurement. 4- 20 mA two-wire transmitter.

Section 9: Analytical Instrumentation and Automation

Classification of analytical instruments, sampling systems, Spectroscopic Techniques: UV–Visible, IR, AAS, Flame photometry, Chromatography: GC, HPLC, detectors (TCD, FID, UV), Electrochemical Methods: pH, potentiometry, conductometry, polarography, Process & Biomedical Analyzers: Gas analyzers (O₂, CO₂), blood gas, pollution monitors, Controllers: PLC, DCS, SCADA basics, Industrial Networks: Fieldbus, Modbus, communication protocols.

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